

Application/Control No

Applicant(s)/Patent under Reexamination
SHIMIZU ET AL.

10/767,171

Examiner

Art Unit

Susan F. Rayyan

2167

SEARCHED					
Class	Subclass	Date	Examiner		
707	10,102 104.1	1/6/2007	SR		
725	60,61	1/6/2007	SR		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
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East	1/6/2007	SR		
IEEE	1/6/2007	SR		
Inventor's Name Search	1/6/2007	SR		
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